

**MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	$V_{CEO}$	15	V
Collector-Base Voltage	$V_{CBO}$	25	V
Emitter-Base Voltage	$V_{EBO}$	12	V
Collector Current — Continuous	$I_C$	150	mA
Operating and Storage Junction Temperature Range	$T_J, T_{stg}$	-55 to +150	°C

**THERMAL CHARACTERISTICS**

Characteristic	Symbol	Max	Unit
*Total Device Dissipation, $T_A = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	1.0 8.0	Watt mW/°C
Storage Temperature	$T_{stg}$	150	°C
*Thermal Resistance Junction to Ambient	$R_{\theta JA}$	125	°C/W

\*Package mounted on 99.5% alumina 10 x 12 x 0.6 mm.

**BFQ18A**

**CASE 354-01, STYLE 1**  
**SOT-89**

**RF-TRANSISTOR**

**NPN SILICON**

**ELECTRICAL CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$  unless otherwise noted.)

Characteristic	Symbol	Min	Max	Unit
<b>OFF CHARACTERISTICS</b>				
Collector-Emitter Breakdown Voltage ( $I_C = 10\text{ mA}$ )	$V_{(BR)CEO}$	15	—	V
Collector-Base Breakdown Voltage ( $I_C = 10\ \mu\text{A}$ )	$V_{(BR)CBO}$	25	—	V
Emitter-Base Breakdown Voltage ( $I_E = 10\ \mu\text{A}$ )	$V_{(BR)EBO}$	2.0	—	V
Collector Cutoff Current ( $V_{CB} = 10\text{ V}$ )	$I_{CBO}$	—	100	nA
Emitter Cutoff Current ( $V_{EB} = 1.0\text{ V}$ )	$I_{EBO}$	—	100	nA
<b>ON CHARACTERISTICS</b>				
DC Current Gain ( $I_C = 50\text{ mA}, V_{CE} = 10\text{ V}$ ) ( $I_C = 100\text{ mA}, V_{CE} = 10\text{ V}$ )	$h_{FE}$	25 25	— —	—
<b>SMALL SIGNAL CHARACTERISTICS</b>				
Current-Gain — Bandwidth Product ( $V_{CE} = 10\text{ V}, I_C = 50\text{ mA}, f = 500\text{ MHz}$ )	$f_T$	3200(1)	—	MHz

(1) Typical only